

<b>Notice of References Cited</b>	Application/Control No. 10/004,629		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Aaron W Carter		Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,714,670 B1	03-2004	Goldsworthy et al.	382/149
*	B	US-6,167,146 A	12-2000	Rogers et al.	382/132
*	C	US-6,608,929 B1	08-2003	Shiratani, Fumiyuki	382/173
*	D	US-6,683,974 B1	01-2004	Nagasawa et al.	382/141
*	E	US-6,177,955 B1	01-2001	Downen et al.	348/189
*	F	US-5,917,957 A	06-1999	Ichikawa, Masayoshi	382/274
*	G	US-5,504,438 A	04-1996	Henley, Francois J.	324/770
*	H	US-4,893,925	01-1990	Sweeney et al.	356/72
*	I	US-5,793,221	08-1998	Aoki, Hiroyuki	324/770
*	J	US-5,650,844	07-1997	Aoki et al.	356/237.2
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.